CS3014

Dual Low-power / Low-voltage Precision Amplifier

Features

- Low Offset:
  - 10 µV Typ.
- Low Drift:
  - 0.05 µV/°C Max.
- Low Noise:
  - 22 nV/√Hz
- Open-loop Voltage Gain:
  - 135 dB Typ.
- Rail-to-Rail Inputs
- Rail-to-Rail Output Swing
  - to within 20 mV of supply voltage
- 1.0 mA Supply Current
- Slew rate:
  - 0.25 V/µs

Applications

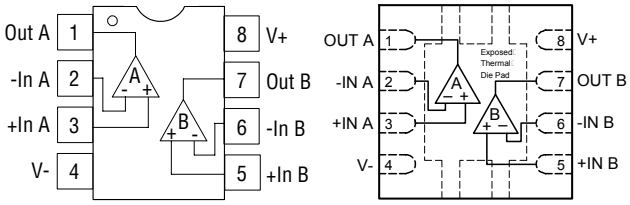
- Thermocouple/Thermopile Amplifiers
- Load Cell and Bridge Transducer Amplifiers
- Precision Instrumentation
- Battery-powered Systems

Description

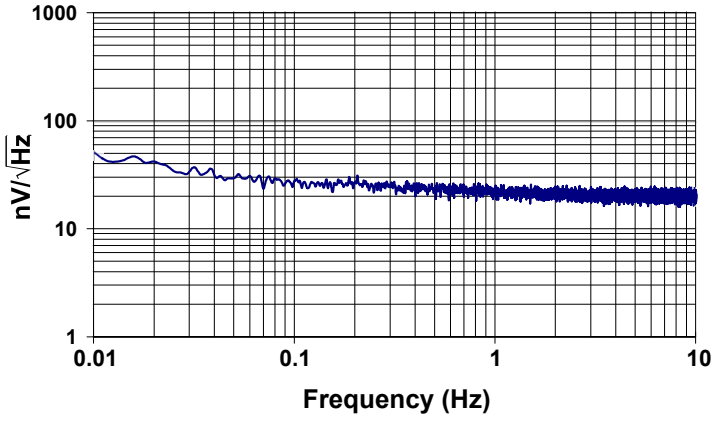
The CS3004 dual amplifier is designed for precision amplification of low-level signals. These amplifiers achieve excellent offset stability, high open loop gain, and low noise. The devices also exhibit excellent CMRR and PSRR. The common mode input range includes the supply rails. The amplifiers operate with any supply voltage from 2.7 V to 5 V (±1.35 V to ±2.50 V).

Pin Configurations

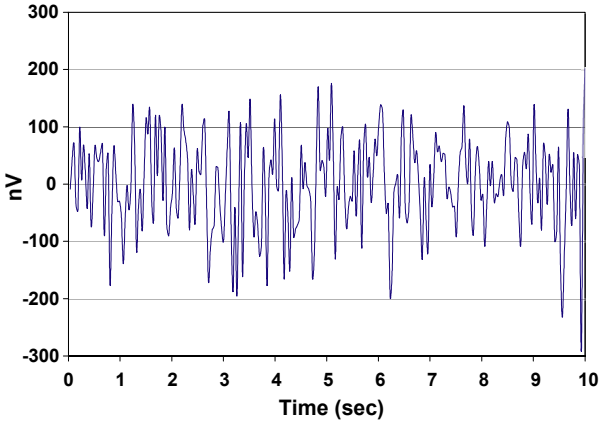
CS3014
(Top View)



8-Lead SOIC **QFN-8**



Noise vs. Frequency (Measured)



0.01 Hz to 10 Hz Noise Performance

Preliminary Product Information | This document contains information for a new product.
Cirrus Logic reserves the right to modify this product without notice.

Cirrus Logic, Inc.
http://www.cirrus.com

JUL '06
DS711PP2

TABLE OF CONTENTS

LIST OF FIGURES

Contacting Cirrus Logic Support

For all product questions and inquiries contact a Cirrus Logic Sales Representative.
To find one nearest you go to **http://www.cirrus.com**

1. CHARACTERISTICS AND SPECIFICATIONS

1.1 5 V Electrical Characteristics

V+ = +5 V, ±5%; V- = 0V; VCM = 2.5 V; Unless otherwise noted, T_A = 25° C (See Note 1).

Parameter			Min	Typ	Max	Unit
Input Offset Voltage	(Note 2)	•	-	±10	±20	µV
Average Input Offset Drift	(Note 2)	•	-	±0.01	±0.05	µV/°C
Input Bias Current		 •	- -	±170 -	±250 ±1.5	pA nA
Input Offset Current		 •	- -	±340 -	±500 ±3.0	pA nA
Input Noise Voltage Density	R_S = 100 Ω, f_0 = 1 Hz R_S = 100 Ω, f_0 = 1 kHz		- -	22 22	- -	$nV/\sqrt{Hz}$ $nV/\sqrt{Hz}$
Input Noise Voltage	0.1 to 10 Hz		-	460	-	nV_{p-p}
Input Noise Current Density	f_0 = 1 Hz		-	100	-	$fA/\sqrt{Hz}$
Input Noise Current	0.1 to 10 Hz		-	1.9	-	pA_{p-p}
Input Voltage Range	(Note 2)	•	V-	-	V+	V
Common Mode Rejection Ratio (dc)		•	105	120	-	dB
Power Supply Rejection Ratio		•	100	120	-	dB
Large Signal Voltage Gain (Note 3)	 R_L = 2 kΩ to V+/2	 •	- 112	145 135	- -	dB dB
Output Voltage Swing (Note 4)	R_L = 2 kΩ to V+/2 R_L = 100 kΩ to V+/2	•	(V+ – 200) (V+ – 20)	- -	(V- + 200) (V- + 20)	mV mV
Slew Rate	R_L = 2 k, 100 pF		-	0.25	-	V/µs
Overload Recovery Time			-	40	-	µs
Supply Current		•	-	1.0	1.25	mA
Oscillator Frequency			-	125	-	kHz
Input Capacitance	Differential Common Mode		- -	1.5 10	- -	pF pF

Notes:
1. Symbol "•" denotes specification applies over -40 to +125 ° C.
2. This parameter is guaranteed by design and/or laboratory characterization.
3. Guaranteed within the output limits of (V+ – 0.2 V) to (V- + 0.2 V).
4. Specifies the worst case drive voltage relative to the supply rail under stated load conditions.

1.2 3 V Electrical Characteristics

V+ = +3 V, ±10%; V- = 0V; VCM = 2.5 V; Unless otherwise noted, T_A = 25º C (See Note 5).

Parameter			Min	Typ	Max	Unit
Input Offset Voltage	(Note 6)	•	-	±10	±20	µV
Average Input Offset Drift	(Note 6)	•	-	±0.01	±0.05	µV/ºC
Input Bias Current		 •	- -	±110 -	±150 ±1.0	pA nA
Input Offset Current		 •	- -	±220 -	±300 ±2.0	pA nA
Input Noise Voltage Density	R_S = 100 Ω, f_0 = 1 Hz R_S = 100 Ω, f_0 = 1 kHz		- -	22 22	- -	$nV/\sqrt{Hz}$ $nV/\sqrt{Hz}$
Input Noise Voltage	0.1 to 10 Hz		-	460	-	nV_{p-p}
Input Noise Current Density	f_0 = 1 Hz		-	100	-	$fA/\sqrt{Hz}$
Input Noise Current	0.1 to 10 Hz		-	1.9	-	pA_{p-p}
Input Voltage Range	(Note 6)	•	V-	-	V+	V
Common Mode Rejection Ratio (dc)		•	105	120	-	dB
Power Supply Rejection Ratio		•	100	120	-	dB
Large Signal Voltage Gain (Note 7)	 R_L = 2 kΩ to V+/2	 •	- 112	145 135	- -	dB dB
Output Voltage Swing (Note 8)	R_L = 2 kΩ to V+/2 R_L = 100 kΩ to V+/2	•	(V+ – 200) (V+ – 20)	- -	(V- + 200) (V- + 20)	mV mV
Slew Rate	R_L = 2 k, 100 pF		-	0.25	-	V/µs
Overload Recovery Time			-	40	-	µs
Supply Current		•	-	1.0	1.25	mA
Oscillator Frequency			-	125	-	kHz
Input Capacitance	Differential Common Mode		- -	1.5 10	- -	pF pF

Notes:
5. Symbol "•" denotes specification applies over -40 to +125 ° C.
6. This parameter is guaranteed by design and laboratory characterization.
7. Guaranteed within the output limits of (V+ – 0.2 V) to (V- + 0.2 V).
8. Specifies the worst case drive voltage relative to the supply rail under stated load conditions.

1.3 Absolute Maximum Ratings

Parameter		Min	Typ	Max	Unit
Supply Voltage	[(V+) – (V-)]	2.7	-	5.5	V
Input Voltage		(V-) – (0.3)	-	(V+) + (0.3)	V
Storage Temperature Range		-65	-	+150	ºC

2. PERFORMANCE PLOTS

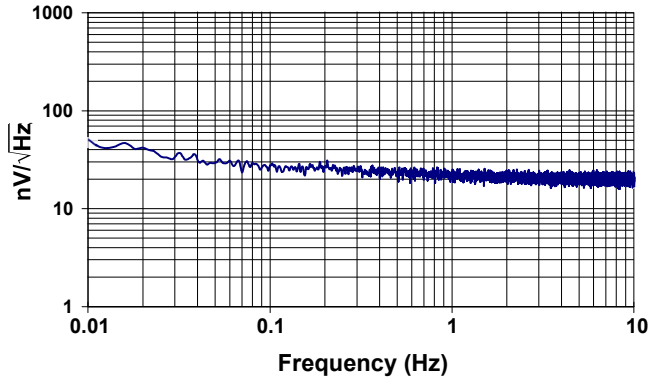


Figure 1. Noise vs Frequency (Measured)

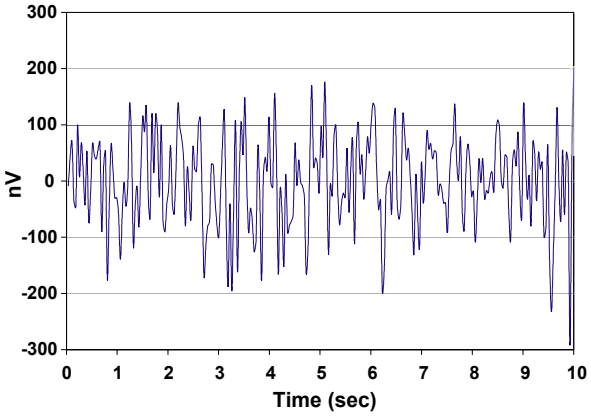


Figure 2. 0.01 Hz to 10 Hz Noise

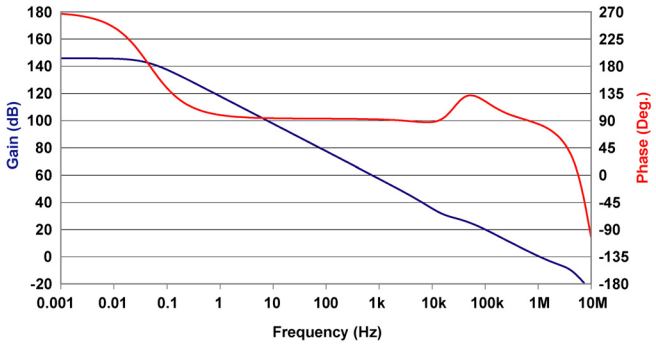


Figure 3. Gain vs. Phase (2.7 V)

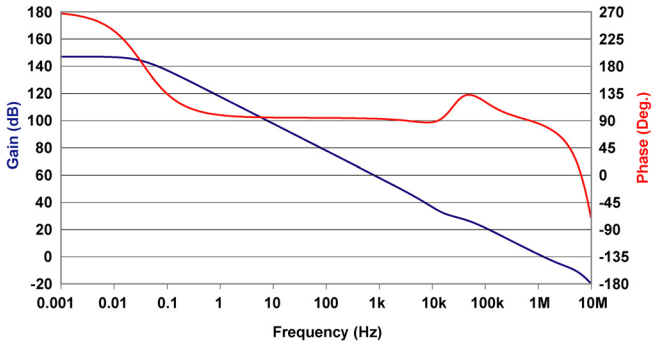


Figure 4. Gain vs. Phase (5 V)

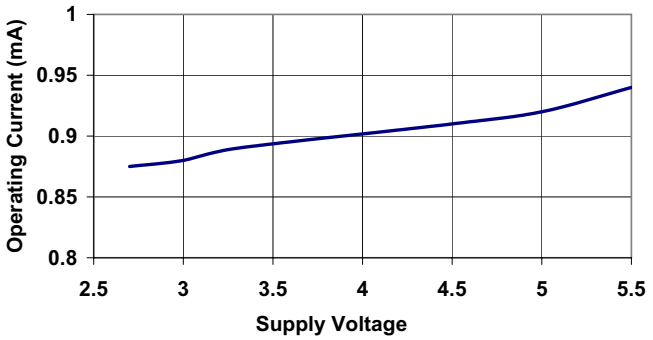


Figure 5. Supply Current vs. Supply Voltage

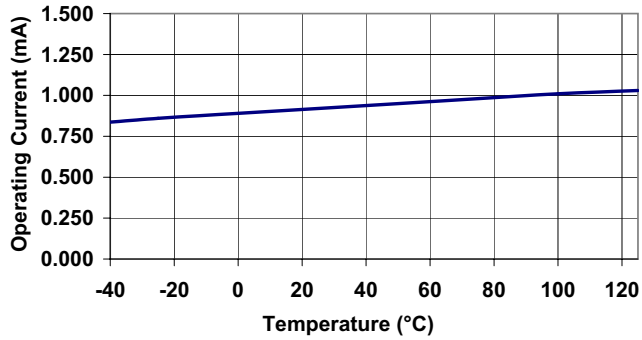
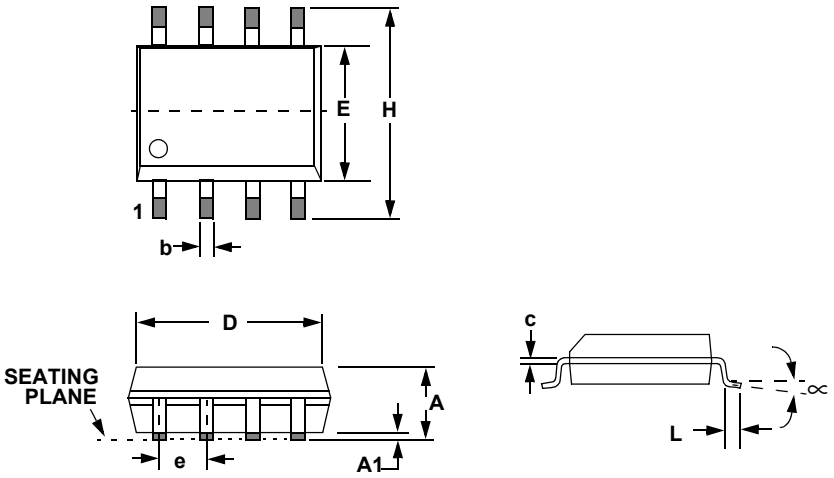


Figure 6. Supply Current vs. Temperature

3. PACKAGE DRAWINGS

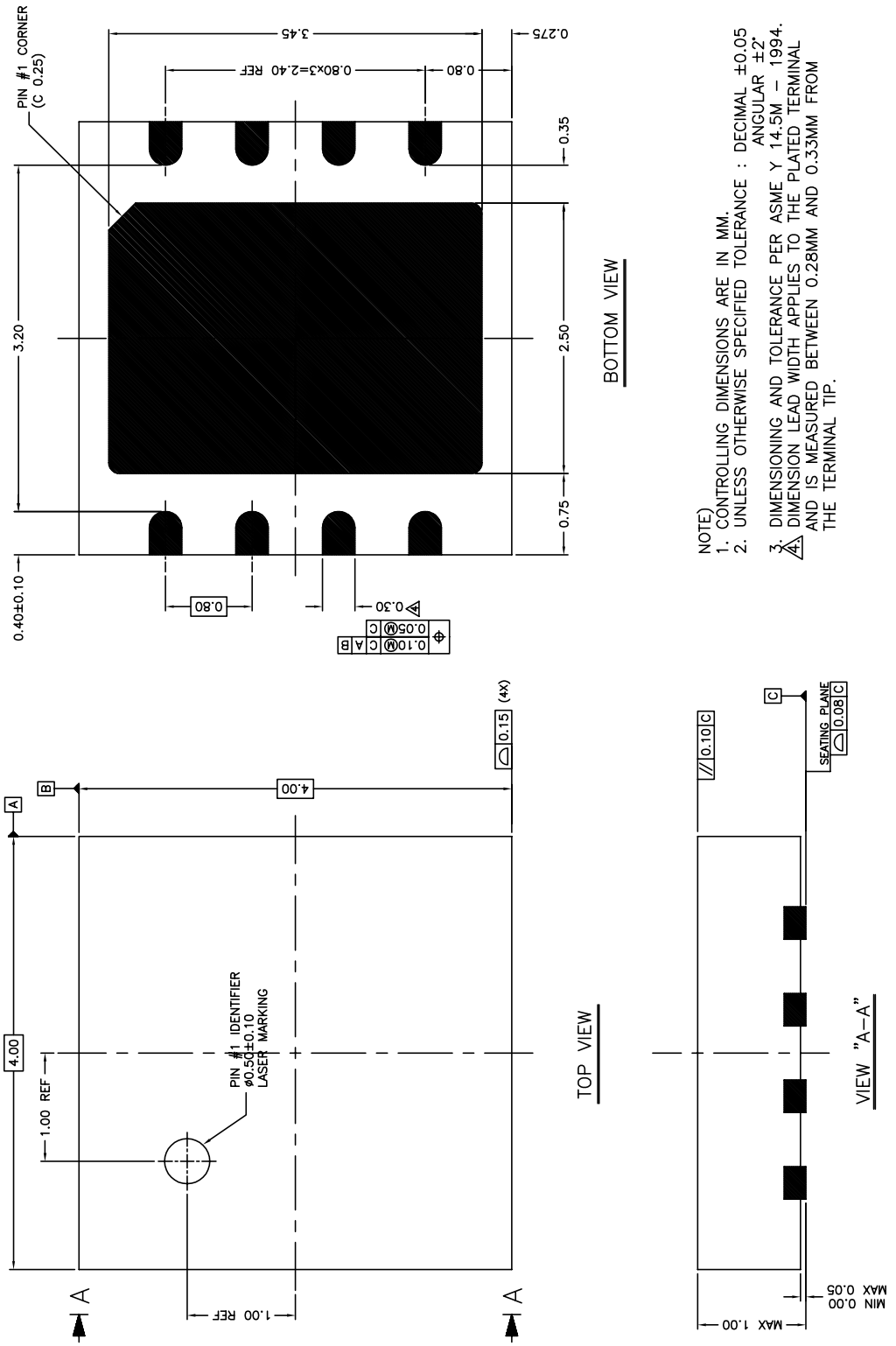
8L SOIC (150 MIL BODY) PACKAGE DRAWING



	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
A	0.053	0.069	1.35	1.75
A1	0.004	0.010	0.10	0.25
B	0.013	0.020	0.33	0.51
C	0.007	0.010	0.19	0.25
D	0.189	0.197	4.80	5.00
E	0.150	0.157	3.80	4.00
e	0.040	0.060	1.02	1.52
H	0.228	0.244	5.80	6.20
L	0.016	0.050	0.40	1.27
∝	0°	8°	0°	8°

JEDEC # : MS-012

8L QFN (4 mm X 4 mm) PACKAGE DRAWING



4. ORDERING INFORMATION

Part #	Temperature Range	Package Description
CS3014-FS	-40 °C to +125 °C	8-lead SOIC
CS3014-FSZ	-40 °C to +125 °C	8-lead SOIC, Lead Free
CS3014-FNZ	-40 °C to +125 °C	8-lead QFN, Lead Free

5. ENVIRONMENTAL, MANUFACTURING, & HANDLING INFORMATION

Model Number	Peak Reflow Temp	MSL Rating*	Max Floor Life
CS3014-FS	240 °C	2	365 Days
CS3014-FSZ	260 °C		
CS3014-FNZ			

* MSL (Moisture Sensitivity Level) as specified by IPC/JEDEC J-STD-020.